


<b>Search Notes</b> 	<b>Application/Control No.</b> 10522601	<b>Applicant(s)/Patent Under Reexamination</b> IMAI ET AL.
	<b>Examiner</b> DAVID Y CHUNG	<b>Art Unit</b> 2871

SEARCHED			
Class	Subclass	Date	Examiner
349	122	8/23/06	/D.C./
349	110	8/23/06	/D.C./

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search report	6/24/07	/D.C./

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
same	same	5/27/08	/D.C./